

5. Future Scope

When we consider an image which has a phase variation i.e. an image which having variation in all the three dimensions the above logic may not work. But the logic can be developed for processing an image in three dimensions. For processing an image in all the three dimensions, a program which processes the length, height and depth of an image is designed. The logic for image retrieving is complete when the images with phase variations are also retrieved. However the logic for such retrieving is still under research.

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